Docket No. 296431US2PCT

IN RE APPLICATION OF: Hisao IGARASHI, et al.

SERIAL NO: 10/593,830

FILED: September 22, 2006

FOR: PROBE APPARATUS, WAFER INSPECTING APPARATUS PROVIDED WITH THE PROBE APPARATUS

AND WAFER INSPECTING METHOD

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR

Transmitted herewith is an amendment in the above-identified application.

No additional fee is required

☐ Small entity status of this application under 37 C.F.R. §1.9 and §1.27 is claimed.

Additional documents filed herewith: Letter Submitting Replacement Drawing Sheet(s)

Replacement Drawing Sheet (1)

The Fee has been calculated as shown below:

CLAIMS	CLAIMS REMAINING		HIGHEST NUMBER PREVIOUSLY PAID	NO. EXTRA CLAIMS		RATE		CALCULATIONS
TOTAL	16	MINUS	20	0	х	\$50	=	\$0.00
INDEPENDENT	2	MINUS	3	0	x	\$210	=	\$0.00
APPLICATION SIZE		MINUS	100	0 (each addtl. 50 sheets)	x	\$260	=	\$0.00
		☐ MULTI	PLE DEPENDE	NT CLAIMS	+	\$370	=	\$0.00
	TOTAL OF ABOVE CALCULATIONS						\$0.00	
	☐ Reduction by 50% for filing by Small Entity					\$0.00		
						ТОТ	AL	\$0.00

\square A check in the amount of \$0.00 is	s attacn	ea.
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- Online credit card payment is being made to cover the fees in the amount of **§0.00**
- Please charge any additional Fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit Account No. 15-0030.
- If these papers are not considered timely filed by the Patent and Trademark Office, then a petition is hereby made under 37 C.F.R. §1.136, and any additional fees required under 37 C.F.R. §1.136 for any necessary extension of time may be charged to Deposit Account No. 15-0030.

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